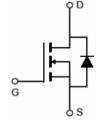


Main Product Characteristics:

V _{DSS}	60V
R _{DS} (on)	6.5mΩ (typ.)
I _D	80A







TO-263 (D2PAK)

Marking

Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating:

Symbol	Parameter	Max.	Units	
In @ TC = 25°C	Continuous Drain Current, Vos @ 10V ①	80		
Ірм	Pulsed Drain Current ②	320	A	
P _D @TC = 25°C	Power Dissipation ③	192	W	
VDS	Drain-Source Voltage	60	V	
Vgs	Gate-to-Source Voltage	± 20	V	
Eas	Single Pulse Avalanche Energy @ L=0.5mH	274	mJ	
Тл Тятс	Operating Junction and Storage Temperature Range			



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
Rejc	Junction-to-case ③		0.65	°C/W

Electrical Characterizes @T_A=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V(BR)DSS	Drain-to-Source breakdown voltage	60	_	_	V	Vgs = 0V, ID = 250µA	
RDS(on)	Static Drain-to-Source on-resistance	_	6.5	8	mΩ	Vgs=10V,ID =20A	
VGS(th)	Gate threshold voltage	2	_	4	V	Vos = Vos, Io =250µA	
IDSS	Drain-to-Source leakage current	_	_	1	μA	Vps =60V,Vgs = 0V	
lgss	Cata to Caurae famuera leakage	_	_	100	n A	Vgs =20V	
IGSS	Gate-to-Source forward leakage	_	_	-100	nA	Vgs = -20V	
Qg	Total gate charge	_	70	_		ID = 30A,	ID = 30A,
Qgs	Gate-to-Source charge	_	16	_	nC	Vps=30V, Vgs = 15V	
Qgd	Gate-to-Drain("Miller") charge	_	23	_			
t d(on)	Turn-on delay time	_	17	_		Vac 40V Vac 20V	
tr	Rise time	_	31.9	_		Vgs=10V, Vps=30V,	
t d(off)	Turn-Off delay time	_	45	_	ns	RGEN=3Ω	
tf	Fall time	_	14.4	_		ID = 30A	
Ciss	Input capacitance		2940	_	Vgs = 0V	Vgs = 0V	
Coss	Output capacitance		178	_	pF	Vps = 50V	
Crss	Reverse transfer capacitance		154	_		f = 100kHz	

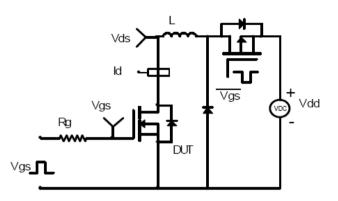
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)	_	_	80	А	MOSFET symbol showing the	
Іѕм	Pulsed Source Current (Body Diode)	_	_	320	А	integral reverse p-n junction diode.	
V _{SD}	Diode Forward Voltage	_	0.87	1.2	V	Is=30A, VGS=0V	
trr	Reverse Recovery Time	_	30	_	ns	la 201 di/dt 1001/us	
Qrr	Reverse Recovery Charge	_	30	_	nC	Is=30A,di/dt=100A/us	

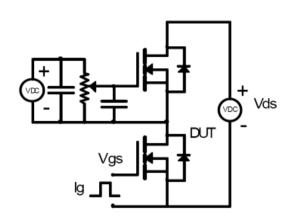


Test Circuits and Waveforms

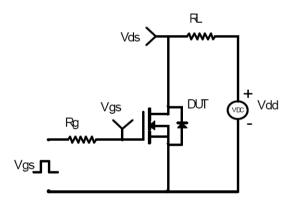
EAS Test Circuit:



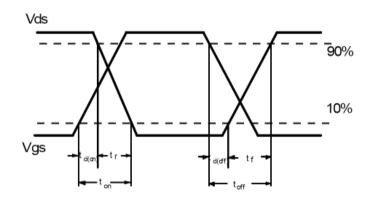
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



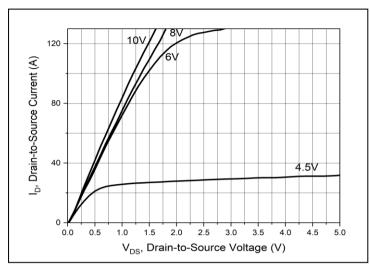
Version: 1.0

Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.



Typical Electrical and Thermal Characteristics



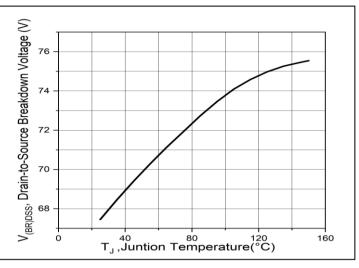
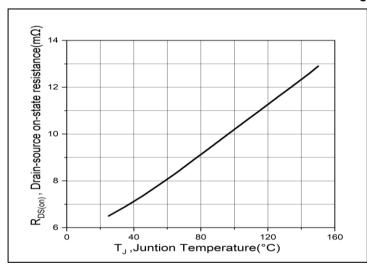


Figure 1. Typical Output Characteristics

Figure 2. Drain-to-Source Breakdown Voltage vs. Junction Temperature



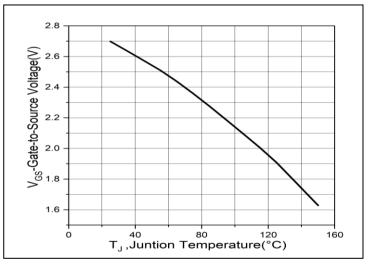
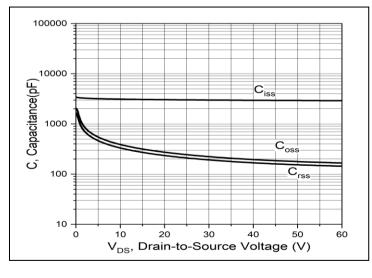


Figure 3. RDS(on) vs. Junction Temperature

Figure 4. Vth vs. Junction Temperature



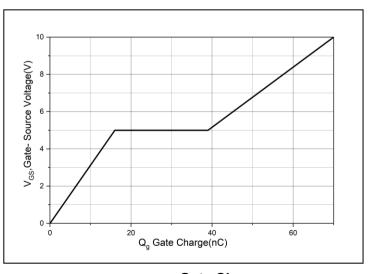


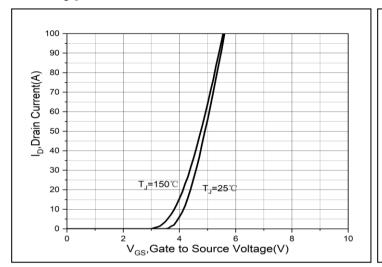
Figure 5. Capacitance

Figure 6. Gate Charge





Typical Electrical and Thermal Characteristics



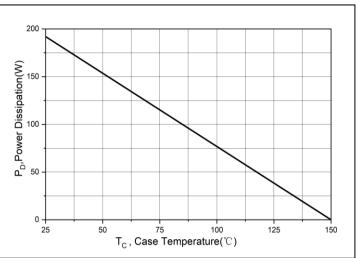


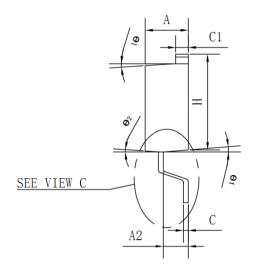
Figure 7. Transfer Characteristics

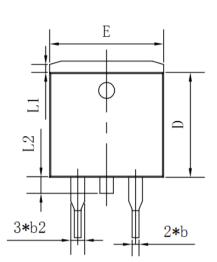
Figure8. Power Dissipation

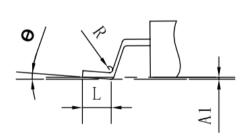


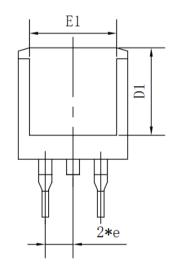
Mechanical Data:

TO-263 Package Outline (Unit:mm)
Option 1







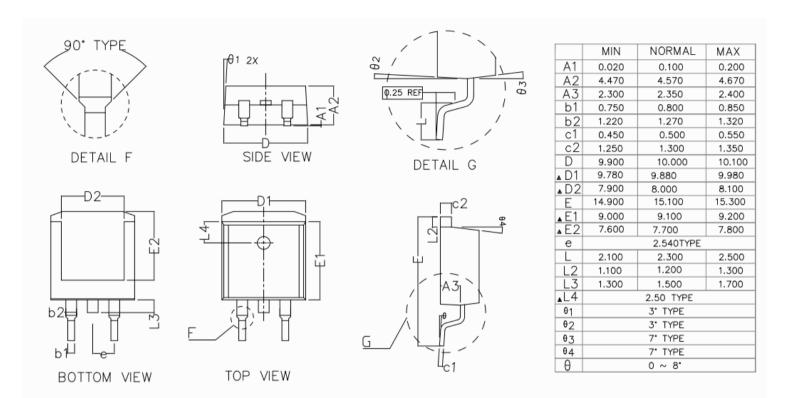


SYMBOL	MIN	NOM	MAX	
A	4. 35	4. 47	4. 60	
A1	0.09	0.10	0.11	
A2	2. 30	2. 40	2. 50	
Ь	0. 70	0.80	1.00	
ь2	1. 25	1. 36	1. 38	
С	0. 45	0.50	0. 55	
C1	1. 29	1. 30	1. 31	
D	9. 10	9. 20	9. 30	
D1	7.90	8.00	8. 10	
Е	9.85	10.00	10. 20	
E1	7.90	8.00	8. 10	
Н	15. 30	15. 50	15. 70	
e	-	2. 54	-	
L	2. 34	2. 54	2. 74	
L1	1. 00	1. 10	1. 20	
L2	1. 30	1. 40	1. 50	
R	0. 24	0. 25	0. 26	
θ	0°	4°	8°	
Θ1	4°	7°	10°	
Θ2	0°	3°	6°	





Option 2







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